



Class II Permissive Change TEST REPORT

Product : IR Thermometer

Trade mark : CliniCloud Model/Type reference : SPL1024

Serial Number : N/A

Report Number : EED32H002011
FCC ID : 2AE7C-SPL1024
Date of Issue : Nov. 19, 2015

Test Standards : 47 CFR Part 15 Subpart C (2014)

Test result : PASS

Prepared for:

CliniCloud Inc.

Level 1, 520 Bourke Street, Melbourne, VIC 3000, Australia

Prepared by:

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Emen-L

Reviewed by:

Nov. 19, 2015

Sheek Luo

Lab supervisor

Check No.:2254747925









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2 Version

Version No.	Date	Description		7
00	Nov. 19, 2015	Original		
	(3)	(3)	Cin	
			(67)	(0,1)

















































































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3 Test Summary

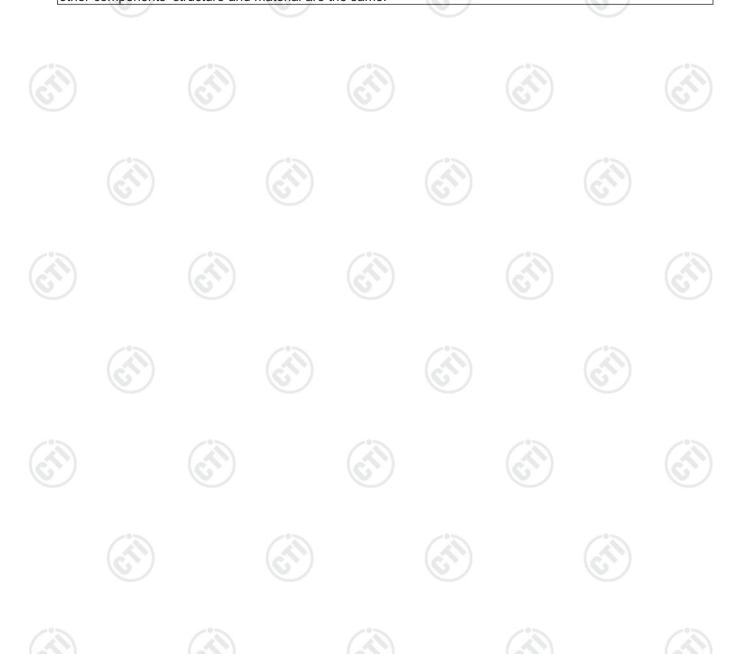
Test Item	Test Requirement	Test method	Result	
Antenna Requirement	47 CFR Part 15Subpart C Section 15.203/15.247 (c)	ANSI C63.10-2013	PASS	
Radiated Spurious Emissions	47 CFR Part 15, Subpart C Section 15.205/15.209	ANSI C63.10-2013	PASS	

Remark:

The tested sample(s) and the sample information are provided by the client.

Model No.: SPL1024

Only the Non-Contact thermometer has changed the front housing material from Aluminum to ABS. All the other components' structure and material are the same.











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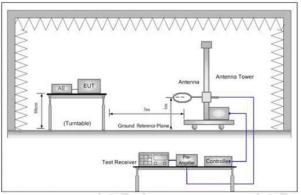
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5 Test Requirement

5.1 Test setup

5.1.1 For Radiated Emissions test setup

Radiated Emissions setup:



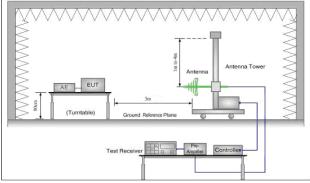


Figure 1. Below 30MHz

Figure 2. 30MHz to 1GHz

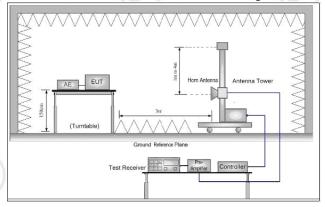


Figure 3. Above 1GHz

5.2 Test Environment

Operating Environment:	(6,5)	(,	(1)	(6.72)	
Temperature:	25 °C				
Humidity:	53 % RH				
Atmospheric Pressure:	995mbar			-0-	

5.3 Test Condition

Test channel:

Test Mode	Tx/Rx	RF Channel				
rest Mode	TX/KX	Low(L)	Low(L) Middle(M) High(
OFOK	04000411 0400 0411	Channel 1	Channel 20	Channel40		
GFSK	2402MHz ~2480 MHz	2402MHz	2440MHz	2480MHz		
Transmitting mode:	The EUT transmitted the continuous modulation test signal at the specific channel(s)					









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6 General Information

6.1 Client Information

Applicant:	CliniCloud Inc.	
Address of Applicant:	Level 1, 520 Bourke Street, Melbourne, VIC 3000, Australia	
Manufacturer:	Shanghai Medical Instruments Co., Ltd	(3)
Address of Manufacturer:	Room 201, 6 th Building, No.515 Ju Jia Qiao Road Shanghai	(8)

6.2 General Description of EUT

Product Name:	IR Thermometer
Model No.(EUT):	SPL1024
Tark mark:	CliniCloud
EUT Supports Radios application:	Bluetooth V4.0 BLE
Power Supply:	1.5(AAA)*2=3.0V
Sample Received Date:	Oct. 19, 2015
Sample tested Date:	Oct. 19, 2015 to Nov. 19, 2015

6.3 Product Specification subjective to this standard

2402MHz~2480MHz		
4.0	(1)	(25)
GFSK	<i></i>	
40		
Portable production	-0-	
Type: Integral		
Gain: 0dBi	(0,)	(6.)
DC 3V		
	4.0 GFSK 40 Portable production Type: Integral Gain: 0dBi	4.0 GFSK 40 Portable production Type: Integral Gain: 0dBi

Operation Frequency each of channel

Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
9	2402MHz	11	2422MHz	21	2442MHz	31	2462MHz
2	2404MHz	12	2424MHz	22	2444MHz	32	2464MHz
3	2406MHz	13	2426MHz	23	2446MHz	33	2466MHz
4	2408MHz	14	2428MHz	24	2448MHz	34	2468MHz
5	2410MHz	15	2430MHz	25	2450MHz	35	2470MHz
6	2412MHz	16	2432MHz	26	2452MHz	36	2472MHz
7	2414MHz	17	2434MHz	27	2454MHz	37	2474MHz
8	2416MHz	18	2436MHz	28	2456MHz	38	2476MHz
9	2418MHz	19	2438MHz	29	2458MHz	39	2478MHz
10	2420MHz	20	2440MHz	30	2460MHz	40	2480MHz















6.4 Description of Support Units

The EUT has been tested independently.

6.5 Test Location

All tests were performed at:

Centre Testing International Group Co., Ltd.

Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong, China518101

Telephone: +86 (0) 755 33683668 Fax:+86 (0) 755 33683385

No tests were sub-contracted.

6.6 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L1910

Centre Testing International Group Co., Ltd.has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC 17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories..

A2LA-Lab Cert. No. 3061.01

Centre Testing International Group Co., Ltd. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

FCC-Registration No.: 565659

Centre Testing International Group Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 565659.

IC-Registration No.: 7408A

The 3m Alternate Test Site of Centre Testing International Group Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 7408A.

IC-Registration No.: 7408B

The 10m Alternate Test Site of Centre Testing International Group Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 7408B.

NEMKO-Aut. No.: ELA503

Centre Testing International Group Co., Ltd. has been assessed the quality assurance system, the testing facilities, qualifications and testing practices of the relevant parts of the organization. The quality assurance system of the Laboratory has been validated against ISO/IEC 17025 or equivalent. The laboratory also fulfils the conditions described in Nemko Document NLA-10.



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VCCI

The Radiation 3 &10 meters site of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-4096.

Main Ports Conducted Interference Measurement of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: C-4563.

Telecommunication Ports Conducted Disturbance Measurement of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: T-2146.

The Radiation 3 meters site of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-758

6.7 Deviation from Standards

None.

6.8 Abnormalities from Standard Conditions None.

6.9 Other Information Requested by the Customer None.

6.10 Measurement Uncertainty (95% confidence levels, k=2)

No.	Item	Measurement Uncertainty
1	Radio Frequency	7.9 x 10 ⁻⁸
2	DE neural conducted	0.31dB (30MHz-1GHz)
	RF power, conducted	0.57dB(1GHz-18GHz)
2	Radiated Spurious emission test	4.5dB (30MHz-1GHz)
3	Radiated Spurious emission test	4.8dB(1GHz-12.75GHz)
	Conduction emission	3.6dB (9kHz to 150kHz)
4	Conduction emission	3.2dB (150kHz to 30MHz)
5	Temperature test	0.64°C
6	Humidity test	2.8%
7	DC power voltages	0.025%











Equipment List

		3M Semi/full-anech	noic Chamber					
Equipment	Manufacturer	Mode No.	Serial Number	Cal. date (mm-dd-yyyy)	Cal. Due date (mm-dd-yyyy)			
3M Chamber	TDK	SAC-3		06-02-2013	06-01-2016			
TRILOG Broadband Antenna	Broadband schwarzbeck		9163-617	07-31-2015	07-29-2016			
Microwave Preamplifier	Agilent	8449B	3008A02425	02-05-2015	02-04-2016			
Horn Antenna	ETS-LINDGREN	3117	00057410	06-30-2015	06-28-2018			
Loop Antenna	ETS	6502	00071730	07-30-2015	07-28-2017			
Spectrum Analyzer	R&S	FSP40	100416	06-30-2015	06-28-2016			
Receiver	R&S	ESCI	100435	06-30-2015	06-28-2016			
Multi device Controller	maturo	NCD/070/10711112		01-13-2015	01-12-2016			
LISN	schwarzbeck	NNBM8125	81251547	06-30-2015	06-28-2016			
LISN	schwarzbeck	NNBM8125	81251548	06-30-2015	06-28-2016			
Signal Generator	Agilent	E4438C	MY45095744	04-19-2015	04-18-2016			
Signal Generator	Keysight	E8257D	MY53401106	04-14-2015	04-13-2016			
Temperature/ Humidity Indicator	TAYLOR	1451	1905	01-14-2015	01-13-2016			
Communication test set	Agilent	E5515C	GB47050533	01-13-2015	01-12-2016			
Cable line	Fulai(7M)	SF106	5219/6A	01-13-2015	01-12-2016			
Cable line	Fulai(6M)	SF106	5220/6A	01-13-2015	01-12-2016			
Cable line	Fulai(3M)	SF106	5216/6A	01-13-2015	01-12-2016			
Cable line	Fulai(3M)	SF106	5217/6A	01-13-2015	01-12-2016			
Communication test set	R&S	CMW500	152394	04-19-2015	04-18-2016			
High-pass filter(3- 18GHz)	Sinoscite	FL3CX03WG18NM 12-0398-002		01-13-2015	01-12-2016			
High-pass filter(5- 18GHz)	MICRO- TRONICS	SPA-F-63029-4		01-13-2015	01-12-2016			
band rejection filter	Sinoscite	FL5CX01CA09CL1 2-0395-001		01-13-2015	01-12-2016			
band rejection filter	Sinoscite	FL5CX01CA08CL1 2-0393-001		01-13-2015	01-12-2016			
band rejection filter	Sinoscite	FL5CX02CA04CL1 2-0396-002	(2)	01-13-2015	01-12-2016			
band rejection filter	Sinoscite	FL5CX02CA03CL1 2-0394-001	<u>6</u>	01-13-2015	01-12-2016			



















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8 Radio Technical Requirements Specification

Reference documents for testing:

		-9-
No.	Identity	Document Title
1	FCC Part15C (2014)	Subpart C-Intentional Radiators
2	ANSI C63.10-2013	American National Standard for Testing Unlicesed Wireless Devices

Test Results List:

Test Requirement	Test method	Test item	Verdict	Note
Part15C Section 15.203/15.247 (c)	ANSI C63.10	Antenna Requirement	PASS	Appendix A)
Part15C Section 15.205/15.209	ANSI C63.10	Radiated Spurious Emissions	PASS	Appendix B)





















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Appendix A) Antenna Requirement

15.203 requirement:

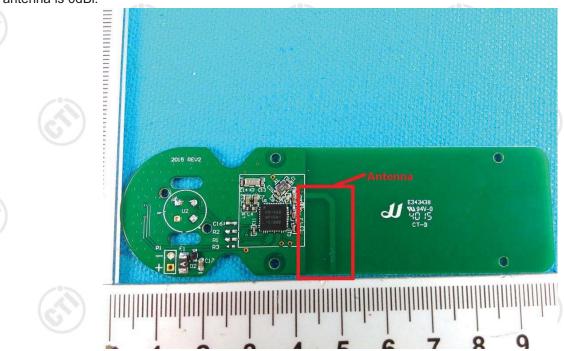
An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna car be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

15.247(b) (4) requirement:

The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentiona radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

EUT Antenna:

The antenna is integrated on the main PCB and no consideration of replacement. The best case gain of the antenna is 0dBi.





































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Appendix B) Radiated Spurious Emissions

Receiver Setup:

Frequency	Detector	RBW	VBW	Remark
0.009MHz-0.090MHz	Peak	10kHz	30kHz	Peak
0.009MHz-0.090MHz	Average	10kHz	30kHz	Average
0.090MHz-0.110MHz	Quasi-peak	10kHz	30kHz	Quasi-peak
0.110MHz-0.490MHz	Peak	10kHz	30kHz	Peak
0.110MHz-0.490MHz	Average	10kHz	30kHz	Average
0.490MHz -30MHz	Quasi-peak	10kHz	30kHz	Quasi-peak
30MHz-1GHz	Quasi-peak	120 kHz	300kHz	Quasi-peak
Above 1GHz	Peak	1MHz	3MHz	Peak
Above IGHZ	Peak	1MHz	10Hz	Average

Test Procedure:

Below 1GHz test procedure as below:

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
- f. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

Above 1GHz test procedure as below:

- g. Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber and change form table 0.8 metre to 1.5 metre(Above 18GHz the distance is 1 meter and table is 1.5 metre).
- h. Test the EUT in the lowest channel ,the middle channel ,the Highest channel
- i. The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, and found the X axis positioning which it is worse case.
- j. Repeat above procedures until all frequencies measured was complete.

1	п	m	IŤ.

	Frequency	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz-0.490MHz	2400/F(kHz)	-	-	300
1	0.490MHz-1.705MHz	24000/F(kHz)	-		30
١	1.705MHz-30MHz	30	-	(C)	30
	30MHz-88MHz	100	40.0	Quasi-peak	3
	88MHz-216MHz	150	43.5	Quasi-peak	3
	216MHz-960MHz	200	46.0	Quasi-peak	3
	960MHz-1GHz	500	54.0	Quasi-peak	3
	Above 1GHz	500	54.0	Average	3

Note: 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.





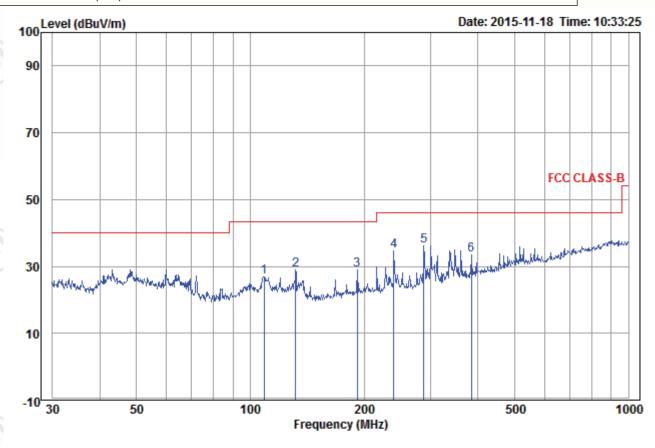




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Radiated Spurious Emissions test Data: Radiated Emission below 1GHz

30MHz~1GHz (QP)



		Ant	Cable	Read		Limit	0ver			
	Freq	Factor	Loss	Level	Level	Line	Limit	Pol/Phase	Remark	
_	MHz	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB			-
1	108.65	12.48	1.57	12.84	26.89	43.50	-16.61	Horizontal		
2	131.76	10.82	1.58	16.62	29.02	43.50	-14.48	Horizontal		
3	191.75	11.32	2.12	15.47	28.91	43.50	-14.59	Horizontal		
4	239.99	12.25	2.32	20.23	34.80	46.00	-11.20	Horizontal		
5 pp	287.99	13.25	2.37	20.65	36.27	46.00	-9.73	Horizontal		
6	383.93	15.84	2.77	14.87	33.48	46.00	-12.52	Horizontal		



















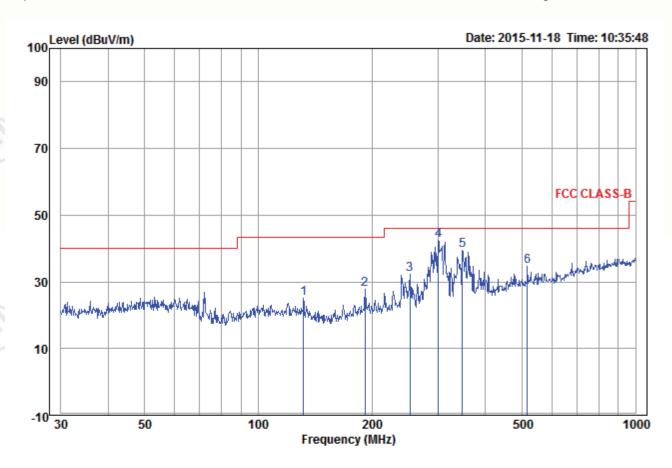








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		Ant	Cable	Kead		Limit	Over		
	Freq	Factor	Loss	Level	Level	Line	Limit	Pol/Phase	Remark
	MHz	dB/m	dB	dBuV	dBuV/m	dBuV/m	——dB		
1	131.76	10.82	1.58	12.67	25.07	43.50	-18.43	Vertical	
2	191.75	11.32	2.12	14.46	27.90	43.50	-15.60	Vertical	
3	252.06	12.45	2.35	17.49	32.29	46.00	-13.71	Vertical	
4 pp	300.37	13.51	2.38	26.70	42.59	46.00	-3.41	Vertical	
5	348.03	14.75	2.70	21.93	39.38	46.00	-6.62	Vertical	
6	517.25	18.47	3.16	12.89	34.52	46.00	-11.48	Vertical	





































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Transmitter Emission above 1GHz

-						1 70 7			- A-0" - A-1	
	Worse case	mode:	GFSK		Test cha	innel:	Lowest			
	Frequency (MHz)	Antenna Factor (dB/m)	Preamp Gain (dB)	Cable Loss (dB)	Read Level (dBµV)	Level (dBµV/m)	Limit Line (dBµV/m)	Over Limit (dB)	Result	Antenna Polaxis
١	1273.572	30.40	38.34	2.6	50.01	44.67	74	-29.33	Pass	Н
	1668.044	31.18	37.72	2.98	48.9	45.34	74	-28.66	Pass	Н
	2390	32.53	37.21	4.28	43.13	42.73	74	-31.27	Pass	Н
	3184.250	33.43	37.06	5.58	46.98	48.93	74	-25.07	Pass	Н
	4804.000	34.69	36.82	5.11	45.4	48.38	74	-25.62	Pass	Н
	7206.000	36.42	37.46	6.66	44.52	50.14	74	-23.86	Pass	Н
	9608.000	37.88	37.82	7.73	43.86	51.65	74	-22.35	Pass	Н
	1457.523	30.79	38.03	2.79	47.41	42.96	74	-31.04	Pass	V
	1529.749	30.93	37.92	2.85	50.84	46.70	74	-27.30	Pass	V
	2390	32.53	37.21	4.28	47.50	47.10	74	-26.90	Pass	V
	2995.538	33.59	37.1	5.61	49.55	51.65	74	-22.35	Pass	V
	4804.000	34.69	36.82	5.11	45.52	48.50	74	-25.50	Pass	V
	7206.000	36.42	37.46	6.66	43.32	48.94	74	-25.06	Pass	V
	9608.000	37.88	37.82	7.73	44.16	51.95	74	-22.05	Pass	V

Worse case	mode:	GFSK		Test cha	nnel:	Middle			
Frequency (MHz)	Antenna Factor (dB/m)	Preamp Gain (dB)	Cable Loss (dB)	Read Level (dBµV)	Level (dBµV/m)	Limit Line (dBµV/m)	Over Limit (dB)	Result	Antenna Polaxis
1399.353	30.67	38.12	2.73	47.11	42.39	74	-31.61	Pass	Н
1846.834	31.47	37.48	3.12	45.70	42.81	74	-31.19	Pass	Н
3766.785	32.97	36.94	5.48	45.64	47.15	74	-26.85	Pass	Н
4883.519	34.86	36.81	5.08	44.14	47.27	74	-26.73	Pass	Н
7320.000	36.43	37.43	6.77	47.46	53.23	74	-20.77	Pass	Н
9760.000	38.05	37.85	7.60	43.79	51.59	74	-22.41	Pass	Н
1593.340	31.04	37.82	2.91	46.09	42.22	74	-31.78	Pass	V
1870.490	31.51	37.45	3.14	45.21	42.41	74	-31.59	Pass	V
3766.785	32.97	36.94	5.48	45.61	47.12	74	-26.88	Pass	V
4880.000	34.85	36.81	5.08	43.07	46.19	74	-27.81	Pass	V
7320.000	36.43	37.43	6.77	45.63	51.40	74	-22.60	Pass	V
9760.000	38.05	37.85	7.60	44.32	52.12	74	-21.88	Pass	V



















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				200				/		
Worse case mode:			GFSK		Test cha	ınnel:	Highest			
Freque (MH:	-	Antenna Factor (dB/m)	Preamp Gain (dB)	Cable Loss (dB)	Read Level (dBµV)	Level (dBµV/m)	Limit Line (dBµV/m)	Over Limit (dB)	Result	Antenna Polaxis
1828.	125	31.44	37.51	3.10	45.39	42.42	74	-31.58	Pass	H
2081.	.55	31.89	37.28	3.47	45.43	43.51	74	-30.49	Pass	Н
2483	5.5	32.71	37.19	4.51	50.89	50.92	74	-23.08	Pass	H
3662.7	775	33.04	36.96	5.50	46.24	47.82	74	-26.18	Pass	Н
4960.0	000	35.02	36.80	5.05	43.01	46.28	74	-27.72	Pass	Н
7440.0	000	36.45	37.41	6.88	45.74	51.66	74	-22.34	Pass	Н
9960.0	000	38.26	37.89	7.44	44.38	52.19	74	-21.81	Pass	Н
1472.4	440	30.82	38.01	2.80	46.94	42.55	74	-31.45	Pass	V
1659.	574	31.16	37.73	2.97	53.65	50.05	74	-23.95	Pass	V
2483	5.5	32.71	37.19	4.51	49.41	49.44	74	-24.56	Pass	V
3342.0	042	33.30	37.02	5.55	45.41	47.24	74	-26.76	Pass	V
4960.0	000	35.02	36.80	5.05	42.79	46.06	74	-27.94	Pass	V
7440.0	000	36.45	37.41	6.88	46.21	52.13	74	-21.87	Pass	V
9920.0	000	38.22	37.88	7.47	45.48	53.29	74	-20.71	Pass	V
- 6	1	•	1.00	A	-				V. P	

Note:

1) The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows:

Final Test Level =Receiver Reading - Correct Factor

Correct Factor = Preamplifier Factor - Antenna Factor - Cable Factor











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PHOTOGRAPHS OF TEST SETUP

Test mode No.: SPL1024



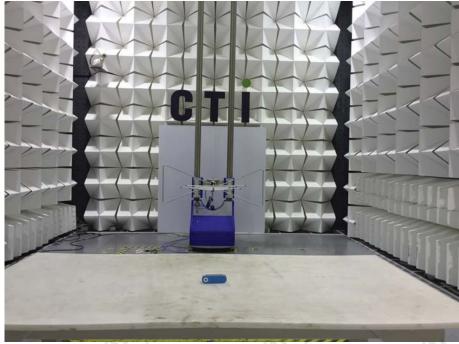












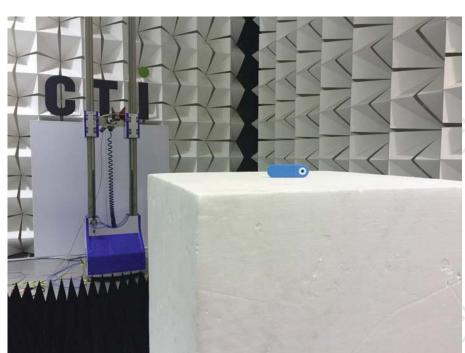












Radiated spurious emission Test Setup-2(Above 1GHz)















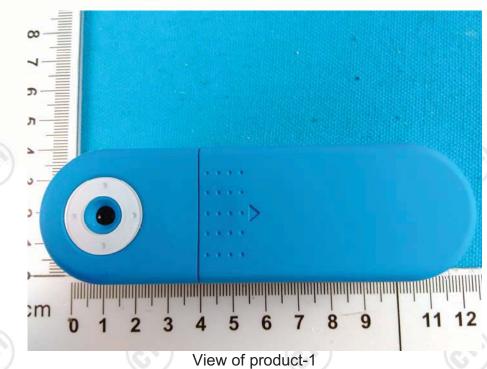


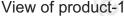


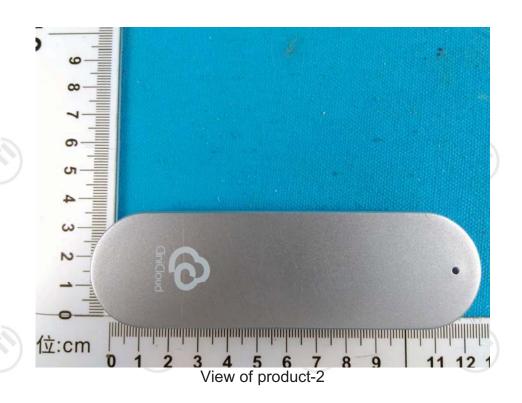
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PHOTOGRAPHS OF EUT Constructional Details

Test mode No.: SPL1024

















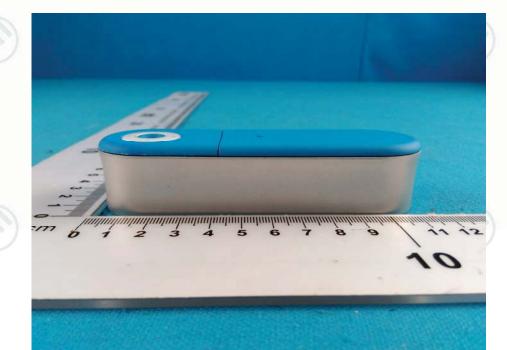








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View of product-3



View of product-4















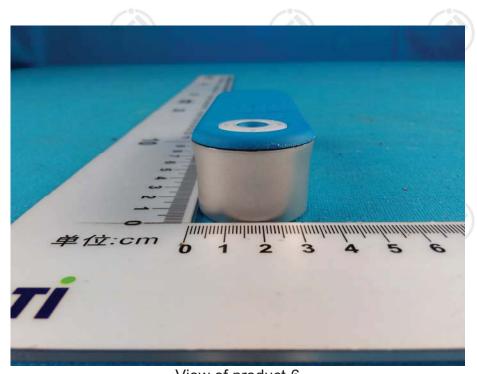








View of product-5



View of product-6













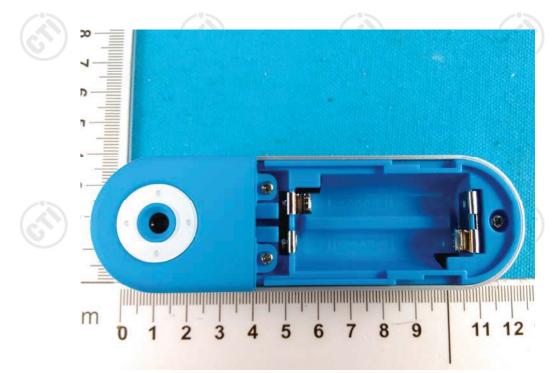


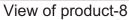






View of product-7









单位:cm









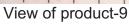


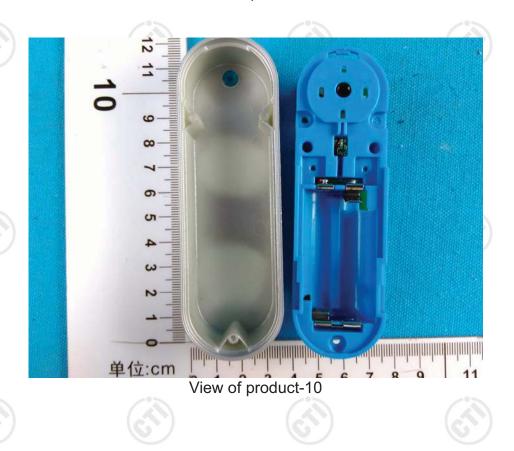




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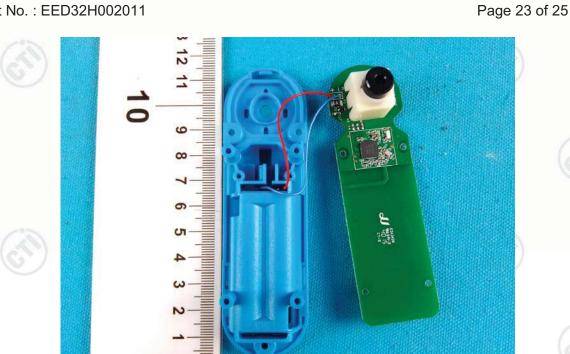




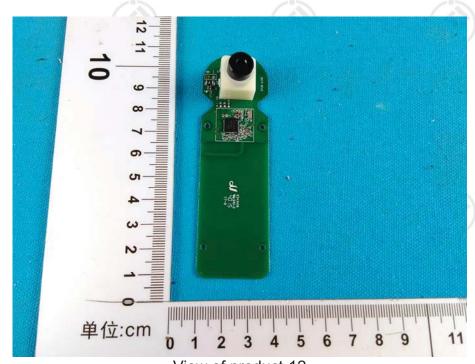








View of product-11



View of product-12











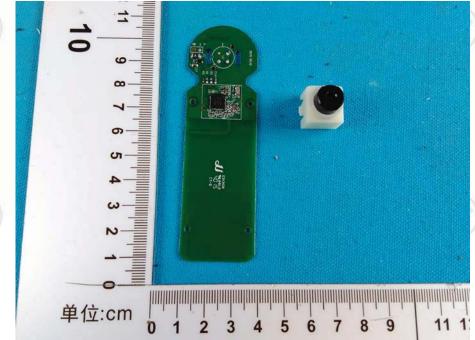




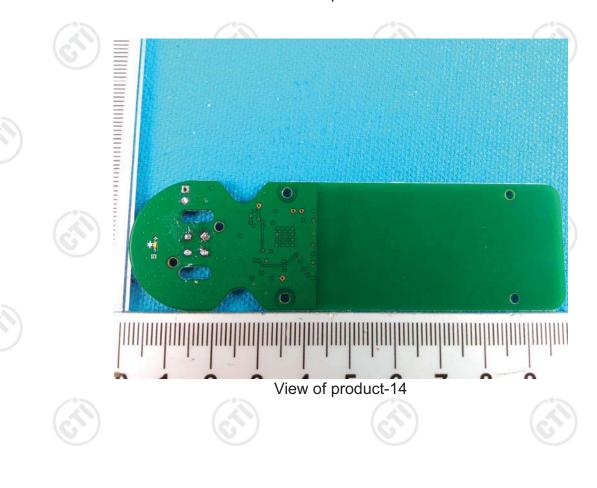








View of product-13













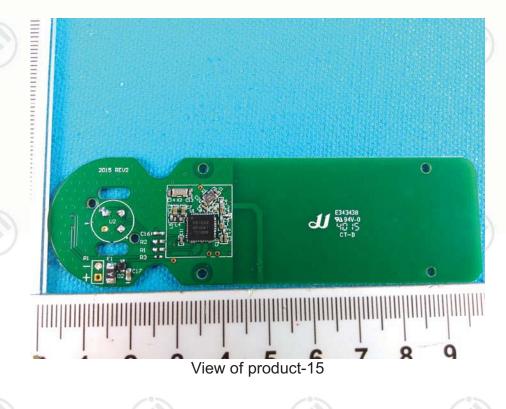








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